| Se | earch | ı Note | es |
|----|-------|--------|----|
|    |       |        |    |

|   | Application/Control No. | Applicant(s)/Patent under Reexamination |  |
|---|-------------------------|---|--|
|   | 10/624,370              | LEE ET AL.                              |  |
|   | Examiner                | Art Unit                                |  |
| ١ | Steven R. Garland       | 2125                                    |  |

| SEARCHED |          |        |          |
|----------|----------|--------|----------|
| Class    | Subclass | Date   | Examiner |
| 700      | 96,121   | 8/8/66 | 5n u     |
|          |          |        |          |
|          |          |        |          |
|          |          |        |          |
|          |          |        |          |
|          |          |        |          |
|          | •        |        |          |
|          |          |        |          |
|          |          |        |          |
|          |          |        |          |

| INTERFERENCE SEARCHED |          |      |          |
|-----------------------|----------|------|----------|
| Çlass                 | Subclass | Date | Examiner |
|                       |          |      |          |
|                       |          |      |          |
|                       |          |      |          |
|                       | 1        |      |          |
|                       |          |      |          |
|                       |          |      |          |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) |         |      |
|--|---------|------|
|  | DATE    | EXMR |
| inventor nond<br>Search on Edan          | 8/7/06  | 500  |
| Plus seuroh see<br>results list          | 7/31/06 | 526  |
| IEEE search, see seunch history          | 8/7/06  | 500  |
| East search                              | 8/8/00  | 5-0  |
|  | ,       |      |
|  |         |      |
|  |         |      |
|  | ·       |      |